

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Complete if Known

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Filing Date	December 31, 2003
First Named Inventor	Sandhu, Sumeet
Group Art Unit	2681
Examiner Name	Unknown

Sheet 1 of 1

Attorney Docket No: 42P18465

US PATENT DOCUMENTS

Examiner Initial *	Cite No ¹	USP Document Number	Publication or Issue Date MM-DD-YYYY	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US-2003123381	07/03/2003	Zhuang, Xiangyang , et al.	

FOREIGN PATENT DOCUMENTS

Examiner Initials *	Cite No ¹	Foreign Patent Document Country Code/Number/Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ²

OTHER DOCUMENTS -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials *	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
		WIEGANDT, D.A. , et al., "High-Performance Carrier Interferometry OFDM WLANs: RF Testing", ISBN: 0-7803-7802-4, volume 1, (5/31/03), 203-207	

EXAMINER**DATE CONSIDERED**